TOSHIBA HN2D02FU

TOSHIBA DIODE SILICON EPITAXIAL PLANAR TYPE

HN2D02FU

ULTRA HIGH SPEED SWITCHING APPLICATION.

HN2D02FU is composed of 3 independent diodes.

• Low Forward Voltage : $V_{F(3)} = 0.98V$ (Typ.)

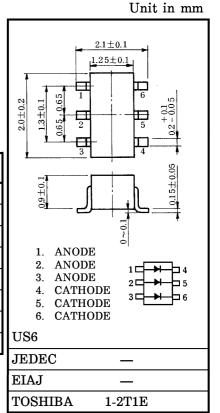
• Fast Reverse Recovery Time: t_{rr}=1.6ns(Typ.)

• Small Total Capacitance : $C_T = 0.5 pF$ (Typ.)

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Maximum (Peak) Reverse Voltage	$v_{ m RM}$	85	V	
Reverse Voltage	$v_{ m R}$	80	V	
Maximum (Peak) Forward Current	$I_{\mathbf{FM}}$	240*	mA	
Average Forward Current	IO	80*	mA	
Surge Current (10ms)	$I_{ ext{FSM}}$	1*	A	
Power Dissipation	P	200	mW	
Junction Temperature	T_{j}	125	°C	
Storage Temperature	$\mathrm{T_{stg}}$	-55~125	°C	

* : This is the Maximum Ratings of single diode (Q1 or Q2 or Q3). In the case of using 2 or 3 diodes, the Maximum Ratings per diode is 75% of the single diode one.



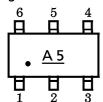
Weight: 6.8mg

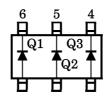
ELECTRICAL CHARACTERISTICS (Q1, Q2, Q3 COMMON, Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Forward Voltage	$V_{F(1)}$	$I_{\mathbf{F}} = 1 \mathbf{m} \mathbf{A}$	_	0.62	_	V
	$V_{F(2)}$	$I_{\mathbf{F}} = 10 \text{mA}$		0.75	_	
	$V_{F(3)}$	$I_{ m F} = 100 { m mA}$		0.98	1.20	
Reverse Currunt	I _{R (1)}	$V_R = 30V$			0.1	μ A
	$I_{R(2)}$	$V_R = 80V$	1		0.5	
Total Capacitance	C_{T}	$V_R = 0$, $f = 1MHz$	_	0.5	3.0	pF
Reverse Recovery Time	t _{rr}	I _F =10mA (Fig. 1)	_	1.6	4.0	ns

Marking

PIN ASSIGNMENT (TOP VIEW)



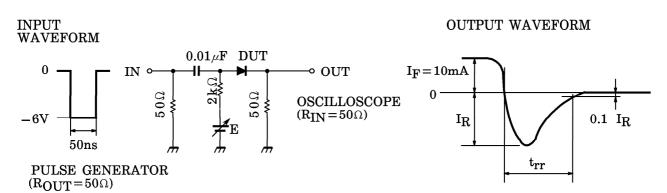


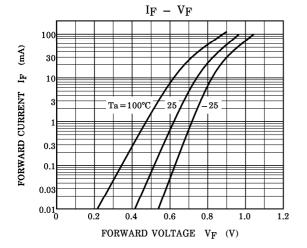
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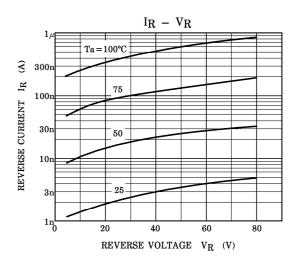
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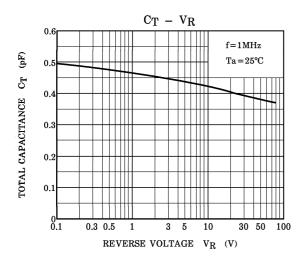
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Fig. 1 : REVERSE RECOVERY TIME (t_{rr}) TEST CIRCUIT









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